

Local-Field-Induced Effective Magnetic Hysteresis of Molecular Magneto-Optical Effects in the Visible Region at Room Temperature: Phthalocyanine Thin Films on Ferromagnetic Inorganic Substrates

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Supporting Information:

Bis(tri-*n*-hexylsiloxy){2,9(or10),16(or17),23(or24)-tetra-*tert*-butylphthalocyanato}silicon,

SiPc(OTHS)₂¹²

Anal. Calcd for C₈₄N₈H₁₂₆O₂Si₃: C, 73.95; H, 9.31; N, 8.21. Found: C, 73.79; H, 8.76; N, 7.39.

MALDI-TOF-mass $m/z = 1362.3$ (M⁺), UV-vis (Toluene) λ/nm ($\epsilon/10^4$) 676 (33), 646 (3.9), 609(4.5), 356(9.4).

Cast films

For preparing thin films, 10 μL of ethanol solution containing 0.19 mM of SiPc(OTHS)₂ were dripped down onto an area determined by masking tapes ((10 \times 15) and (5 \times 15) mm² for Ni and SrO·6Fe₂O₃ substrates, respectively). Although cast films prepared by using CHCl₃ or toluene were obviously inhomogeneous, the relatively homogeneous cast films were easily prepared by using EtOH as a solvent, which covered the most parts of the substrates. The thicknesses of the cast films (~20 and ~32 nm for Ni and SrO·6Fe₂O₃ substrates, respectively) were evaluated from the molecular space of SiPc(OTHS)₂ (1.6 \times 1.6 \times 1.45 nm³/mole evaluated from the optimized structure calculated using the PM3 Hamiltonian, Fig. 1) and the number of moles of SiPc(OTHS)₂, which was evaluated by extracting SiPc with toluene and measuring the absorbance at the Q band. This evaluation method was supported by a fact that the molecular space calculated was consistent with the nitrogen adsorption-desorption measurements.¹³ The AFM measurements indicate that it was unfortunately difficult to determine the small thickness (a few tens of nanometres), since the roughness of the substrates was a few hundreds of nanometres.

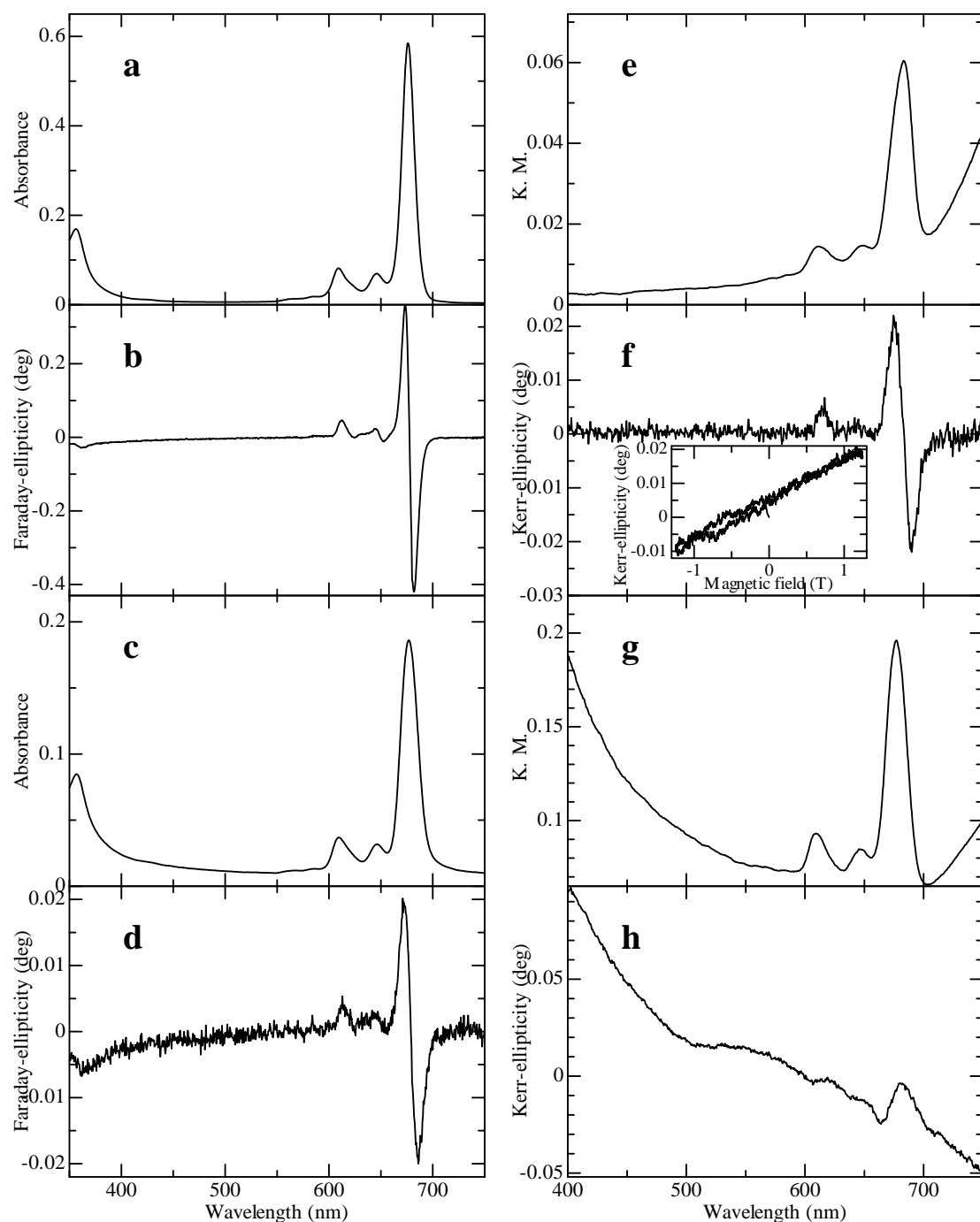


Fig. S1 Diffuse transmission (a, c), diffuse reflection (e, g), Faraday-ellipticity (b, d), and Kerr-ellipticity (f, h) spectra of SiPc(OTHS)₂. These spectra were measured in toluene solution (a, b), as a film on a glass substrate (c, d), as a film on an Al substrate (e, f), and as a film on a Ni substrate (g, h), respectively. The spectroscopic properties of thin films, such as the sharp Q absorption band and intense magneto-optical signal, are similar to those of toluene solution. Inset (f) shows the magnetic field dependence of Kerr-ellipticity (675 nm) in the case of SiPc(OTHS)₂ on the Al substrate. Because of the diamagnetic Al substrate, the magneto-optical signal increases in proportion to the external magnetic field strength.

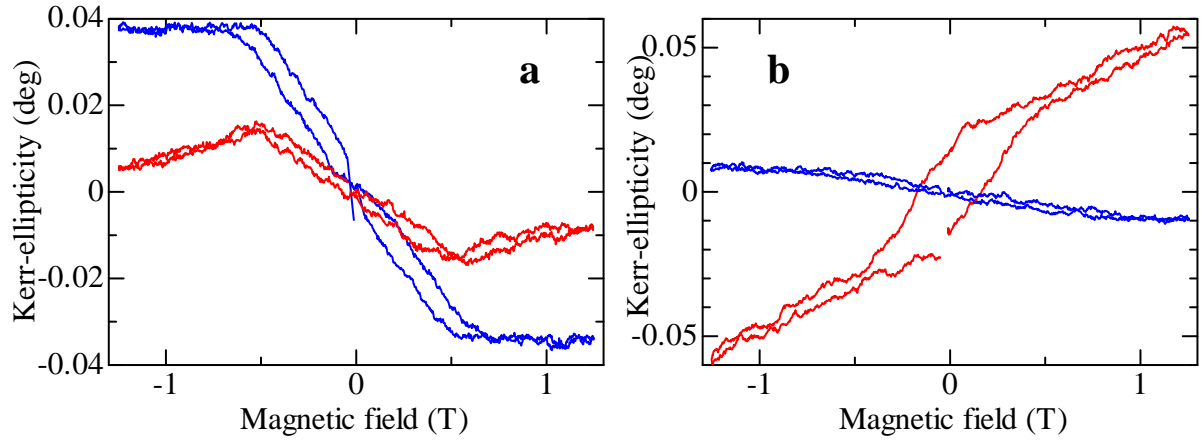


Fig. S2 Magnetic field dependences of Kerr-ellipticity (680 nm) for SiPc(OTHS)₂ films (red line) on Ni (a) and SrO·6Fe₂O₃ (b) substrates. The blue lines show magnetic field dependences of Kerr-ellipticity (680 nm) for the Ni (a) and SrO·6Fe₂O₃ (b) substrates. In the case of SiPc(OTHS)₂ on SrO·6Fe₂O₃, the magnetic hysteresis (680 nm) of Kerr-ellipticity is clearly attributed to SiPc(OTHS)₂ interacting with SrO·6Fe₂O₃ (Fig. 3f), since the magneto-optical signal due to SrO·6Fe₂O₃ is negligibly small compared with that due to SiPc(OTHS)₂. In the case of Ni, the deduction is also meaningful, since the slope change by adding SiPc(OTHS)₂ is obviously larger at the low magnetic field region than that at the high magnetic field region.